Se	arch	Note	S

Application/Control No.	Applicant(s)/Patent under Reexamination
10/005,548	LIN ET AL.
Examiner	Art Unit
Tom Y. Lu	2621

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	SEARCHED			
Class	Subclass	Date	Examiner	
382	170, 181, 209, 217	7/7/2005	TYL	
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			1

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST search printout attached	7/7/2005	TYL <sub>.</sub>
		1